

Notice of References Cited		Application/Control No. 10/765,264	Applicant(s)/Patent Under Reexamination PAPPIN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0194717	10-2003	Schmidt et al.	435/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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